

Search Notes

Application/Control No.

10/671,197

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under
Reexamination

PATZ ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	260 264 270 422 423 908	3/13/07	QN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub, USPAT	3/13/07	QN
Inventor searched through PALM database	3/13/07	QN